Search Notes

Application/Control N	0
00/805 008	

Applicant(s)/Patent under Reexamination

09/895,098 Examiner

Fadey S. Jabr

BANERJEE ET AL.
Art Unit

3639

SEARCHED					
Class	Subclass	Date	Examiner		
705	5, 6	7/29/2005	FSJ		
340	825.28	7/29/2005	FSJ		
455	414.3	7/29/2005	FSJ		
719	311	7/29/2005	FSJ		
		·			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		· · · · · · · · · · · · · · · · · · ·			

SEARCH (INCLUDING SEAR		TEGY)	
		TE	EXMR
East Search, see attached	7/29/	2005	FSJ
EIC Plus Search	7/28/	2005	FSJ
EIC Search, see attached	7/29/	2005	FSJ
		:	